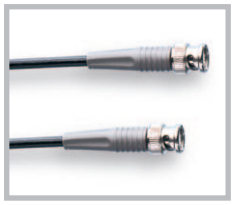
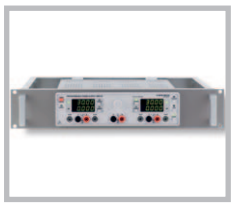
3 GHz Programmable Counter HM8123

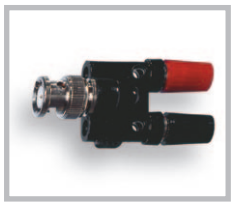
HZ33, HZ34
Test cable BNC/BNC



HZ42 19" Rackmount kit 2RU



HZ20 Connector
BNC to 4 mm socket



- Frequency range from 0 Hz to 3 GHz
- 400 MHz time base with 0.5 ppm stability
- 2 identical inputs, up to 200 MHz each
- 9-digit resolution at 1 sec. gate time
- 9 measurement functions, external gate and arming
- Input for external time base (10 MHz)
- Display modes: numeric, histograms or trend plots
- OCXO optional
- RS-232 Interface
  optional: USB, IEEE-488

RS-232 | optional IEEE-488 | optional USB

3 GHz Programmable Counter HM8123

Valid at 23 °C after a 30 minute warm-up period

Input characteristics (Input A and B)

Connection:	BNC socket	
Frequency range:		
0 – 200 MHz	(DC-coupled)	
10 Hz – 200 MHz	(1 MΩ, AC-coupled)	
500 kHz – 200 MHz	(50 Ω, AC-coupled)	
Input impedance:	1 MΩ II 30 pF or 50 Ω (switchable)	
Attenuation:	1:1, 1:10, 1:100 (selectable)	
Sensitivity: (normal triggering)		
0 to 80 MHz	25 mV_{rms} (sine wave), 80 mV_{pp} (pulse)	
80 MHz to 200 MHz	65 mV_{rms} (sine wave)	
20 Hz to 80 MHz	50 mV_{rms} (sine wave, auto trigger)	
Trigger (programmable via encoder or software)		
Attenuation:	**Trigger level:**	**Resolution:**
1:1	0 to ± 2 V	1 mV
1:10	0 to ± 20 V	10 mV
1:100	0 to ± 200 V	100 mV
Max. input voltage:		
Input 1 MΩ:	250 V (DC + AC_{peak}) from 0 to 440 Hz decreasing to 8 V_{rms} at 1 MHz	
Input 50 Ω:	5 V_{rms}	
Minimum pulse duration:	‹5 ns for single pulse	
Input noise:	(typ.) 100 µV	
Auto trigger (AC coupling):	trigger point: 50 % of peak-to-peak value	
Trigger slope:	positive or negative	
Filter:	100 kHz low-pass filter (switchable)	

Input characteristics (Input C)

Connection:	SMA socket	
Frequency range:	100 MHz - 3 GHz	
Input sensitivity:	up to 1 GHz:	30 mV_{rms} (typ. 20 mV_{rms})
	1 GHz-3 GHz:	100 mV_{rms} (typ. 80 mV_{rms})
Input impedance:	50 Ω nominal	
Max. input voltage:	5 V (DC + AC_{peak})	

Input characteristics

	External Reset	Reference	Gate/Arming
Input impedance:	5 kΩ	500 Ω	5 kΩ
Max. input voltage:	± 30 V	± 20 V	± 30 V
Input sensitivity:	-	typ. 2 V_{pp}	-
High level:	› 2 V	-	› 2 V
Low level:	‹ 0.5 V	-	‹ 0.5 V
Min. pulse duration:	200 ns	-	50 ns
Input frequency:	-	10 MHz	-
Min. eff. gate time:	-	-	20 µs

Measurement functions

Frequency A/B/C; period duration A; width A; duty cycle A; totalize A; RPM A; frequency ratio A:B; time interval A:B; time interval A:B (average); phase A to B; Duty cycle A; burst measurements

Frequency measurement (Inputs A, B, C)

Frequency range:	0 to 200 MHz (3 GHz)
LSD:	(1.25 x 10^{-8} s x frequency) / measurement time
Resolution:	± 1 or 2 LSD
Accuracy:	± (resolution / frequency ± time inaccuracy ± trigger error[2] / measurement time)

Period duration measurement

Range:	10000 sec. to 5 ns
LSD:	(1.25 x 10^{-8} s x period) / measurement time
Resolution:	1 or 2 LSD
Accuracy:	± resolution / period ± (trigger error[2] B / measurement time)

Totalization A

	(manual control)	(external control)
Range:	0 – 200 MHz	0 – 200 MHz
Min. pulse duration:	10 ns	10 ns
LSD:	1 count	± 1 count
Resolution:	LSD	LSD
Accuracy:	(resolution ± ext. gate time error x frequency A)/total	
Pulse resolution:	10 ns	10 ns
Ext. gate error:	-	100 ns

Time interval / Average time interval

(Input A = start; input B = stop)

LSD:	10 ns (10 ns to 1 ps in "average" mode)	
Resolution:	1 LSD (1 or 2 in "average" mode)	
Accuracy:	± (resolution + trigger error[2] + system error) / time interval ± time basis uncertainty (system error: ≤ 4 ns)	
Number of average:	N = 1-25	LSD = 10 ns
	N = 26-2500	LSD = 1 ns
	N = 2501-250000	LSD = 100 ps
	N = 250001 – 25000000	LSD = 10 ps
	N = › 25000000	LSD = 1 ps

RPM measurement

NPR[1] presetting:	1 – 65535 pulses per revolution
Gate time:	330 ms fixed
LSD:	7.5 x 10^{-8} revolution speed
Resolution:	1 or 2 LSD
Accuracy:	± (trigger error[2] / 0.33) ± time basis error

Offset

Range: Covers the entire measurement range

Resolution: Same resolution as in normal measurement.
If the gate time is changed in the offset mode, the offset resolution is the reference value resolution or the current reading resolution (whichever is less precise).

Gate time

Range:	1 ms – 65 sec.
Resolution:	1 ms
External gate time:	min. 20 µs

Time base

Frequency:	400 MHz clock rate; 10 MHz crystal
Stability:	± 5 x 10^{-7} between +10° C and +40° C
Ageing:	‹ 0.27 ppm per month, 0.05 ppm per day
External Reference:	10 MHz ± 20 ppm

Miscellaneous

Interface:	RS-232 (serial), IEEE-488 (optional), USB (optional)
Safety class:	Safety Class I (EN61010-1)
Display:	LCD display (83 x 21 mm)
Power supply:	115/230 V ± 10 %, 45-60 Hz, 40 VA
Operating temperature:	+10° C to +40° C
Max. relative humidity:	10 %-90 % (without condensation), 5 %-95 % RH
Dimensions (W x H x D):	285 x 75 x 365 mm
Weight:	approx. 4 kg

[1] NPR=number of pulses per revolution
[2] Trigger error= ± noise input (V_{pp}) / slew rate of the input signal

Accessories supplied: Operator's Manual and power cable
Optional accessories:
HZ10S/R Silicone test lead
HZ42 19" Rackmount kit 2RU
HZ33/34 Test cable 50 Ω (BNC-BNC)
HZ24 Attenuators 50 Ω
HZ20 Adapter plug
HO870 USB Interface
HO880 IEEE-488 interface
HO85 OCXO (Installation only ex factory)

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